

Notice of References Cited

Application/Control No.

10/530,436

Applicant(s)/Patent Under
Reexamination
SHEN ET AL.

Examiner

HEE SOO KIM

Art Unit

2457

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0143972 A1	10-2002	Christopoulos et al.	709/231
*	B	US-2003/0156108 A1	08-2003	Vetro, Anthony	345/418
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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